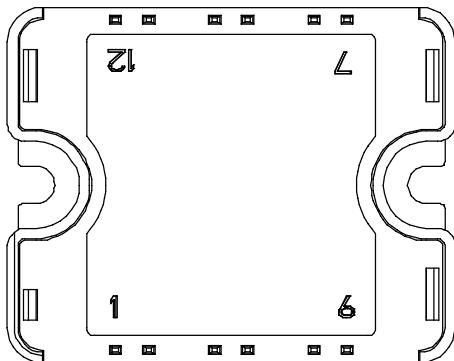
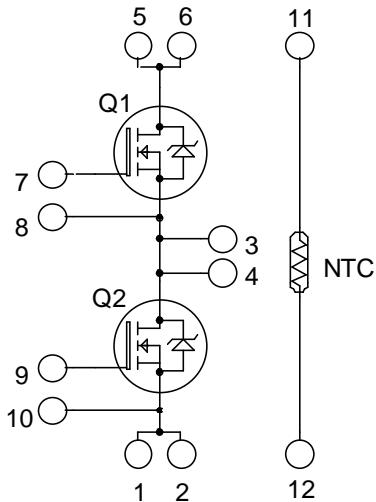


*Phase leg*  
*MOSFET Power Module*

**V<sub>DSS</sub> = 1200V**  
**R<sub>DSon</sub> = 650mΩ typ @ T<sub>j</sub> = 25°C**  
**I<sub>D</sub> = 16A @ T<sub>c</sub> = 25°C**



Pins 1/2 ; 3/4 ; 5/6 must be shorted together

#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- Power MOS 8™ Fast FREDFETs
  - Low R<sub>DSon</sub>
  - Low input and Miller capacitance
  - Low gate charge
  - Fast intrinsic reverse diode
  - Avalanche energy rated
  - Very rugged
- Very low stray inductance
  - Symmetrical design
- Internal thermistor for temperature monitoring
- High level of integration

#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

#### Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V <sub>DSS</sub>	Drain - Source Breakdown Voltage	1200	V
I <sub>D</sub>	Continuous Drain Current	T <sub>c</sub> = 25°C	16
		T <sub>c</sub> = 80°C	12
I <sub>DM</sub>	Pulsed Drain current	105	
V <sub>GS</sub>	Gate - Source Voltage	±30	V
R <sub>DSon</sub>	Drain - Source ON Resistance	780	mΩ
P <sub>D</sub>	Maximum Power Dissipation	T <sub>c</sub> = 25°C	390
I <sub>AR</sub>	Avalanche current (repetitive and non repetitive)		14
			A

 **CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

All ratings @  $T_j = 25^\circ\text{C}$  unless otherwise specified

**Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 1200V V <sub>GS</sub> = 0V	T <sub>j</sub> = 25°C T <sub>j</sub> = 125°C			250	μA	
R <sub>DS(on)</sub>	Drain – Source on Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 14A			650	780	μΩ	
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 2.5mA		3	4	5	V	
I <sub>GSS</sub>	Gate – Source Leakage Current	V <sub>GS</sub> = ±30 V				±100	nA	

**Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V V <sub>DS</sub> = 25V f = 1MHz			7736		pF
C <sub>oss</sub>	Output Capacitance				715		
C <sub>rss</sub>	Reverse Transfer Capacitance				92		
Q <sub>g</sub>	Total gate Charge	V <sub>GS</sub> = 10V V <sub>Bus</sub> = 600V I <sub>D</sub> = 14A			300		nC
Q <sub>gs</sub>	Gate – Source Charge				50		
Q <sub>gd</sub>	Gate – Drain Charge				140		
T <sub>d(on)</sub>	Turn-on Delay Time	Resistive switching @ 25°C V <sub>GS</sub> = 15V V <sub>Bus</sub> = 800V I <sub>D</sub> = 14A R <sub>G</sub> = 2.2Ω			50		ns
T <sub>r</sub>	Rise Time				31		
T <sub>d(off)</sub>	Turn-off Delay Time				170		
T <sub>f</sub>	Fall Time				48		

**Source - Drain diode ratings and characteristics**

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I <sub>S</sub>	Continuous Source current (Body diode)		T <sub>c</sub> = 25°C			16	A
			T <sub>c</sub> = 80°C			12	
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> = 0V, I <sub>S</sub> = - 14A				1.1	V
dv/dt	Peak Diode Recovery ①					25	V/ns
t <sub>rr</sub>	Reverse Recovery Time	I <sub>S</sub> = - 14A V <sub>R</sub> = 100V di <sub>S</sub> /dt = 100A/μs	T <sub>j</sub> = 25°C			335	ns
			T <sub>j</sub> = 125°C			640	
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>S</sub> = - 14A V <sub>R</sub> = 100V di <sub>S</sub> /dt = 100A/μs	T <sub>j</sub> = 25°C		1.72		μC
			T <sub>j</sub> = 125°C		4.67		

① dv/dt numbers reflect the limitations of the circuit rather than the device itself.

 I<sub>S</sub> ≤ - 14A    di/dt ≤ 1000A/μs    V<sub>DD</sub> ≤ 800V    T<sub>j</sub> ≤ 125°C

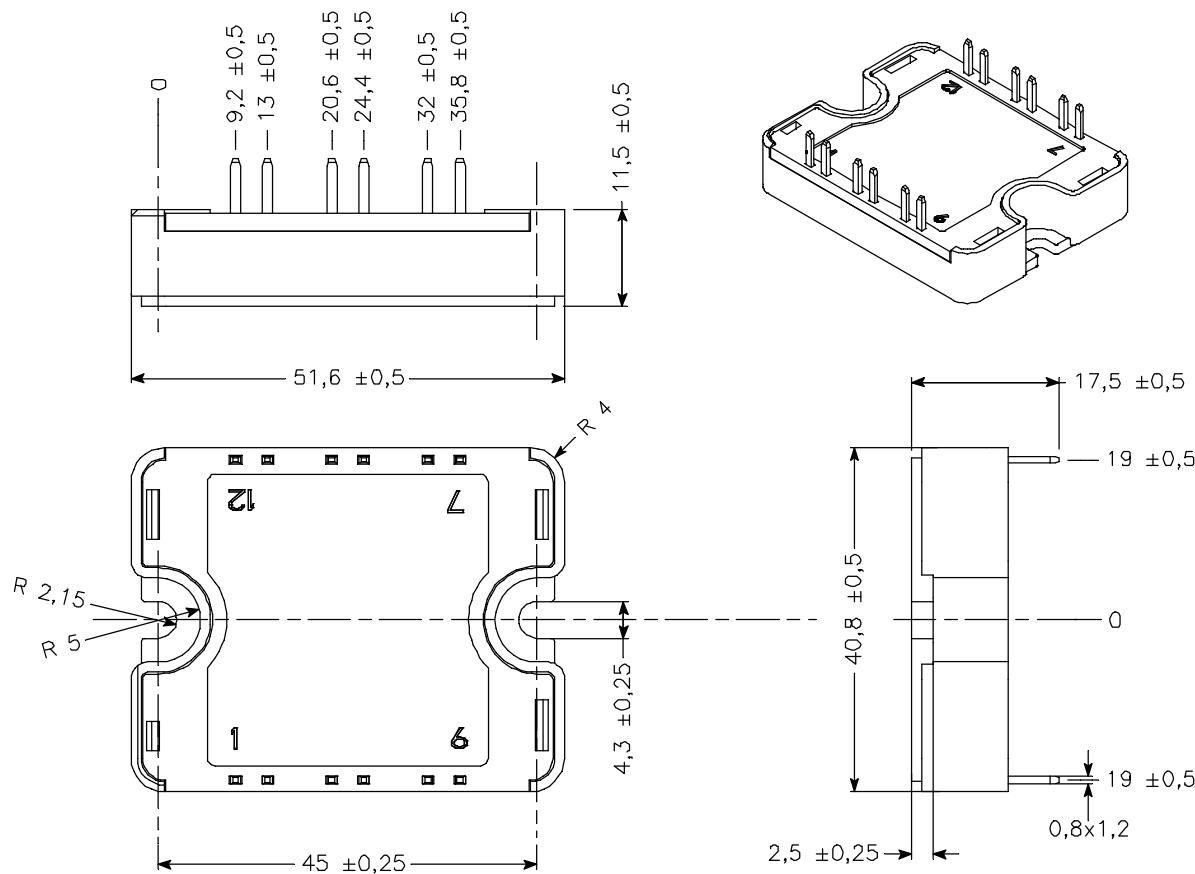
**Thermal and package characteristics**

Symbol	Characteristic		Min	Typ	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance				0.32	°C/W
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, I isol<1mA, 50/60Hz		2500			V
T <sub>J</sub>	Operating junction temperature range		-40		150	
T <sub>STG</sub>	Storage Temperature Range		-40		125	°C
T <sub>C</sub>	Operating Case Temperature		-40		100	
Torque	Mounting torque	To heatsink	M4	2.5	4.7	N.m
Wt	Package Weight				80	g

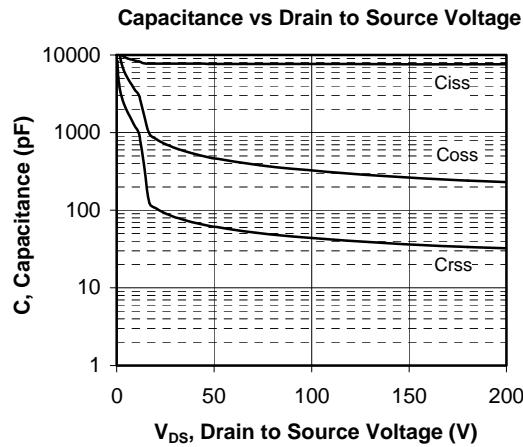
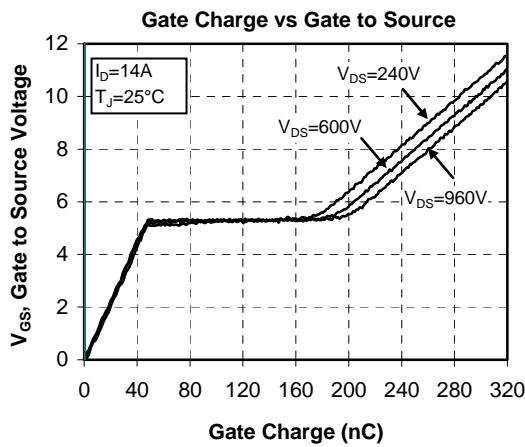
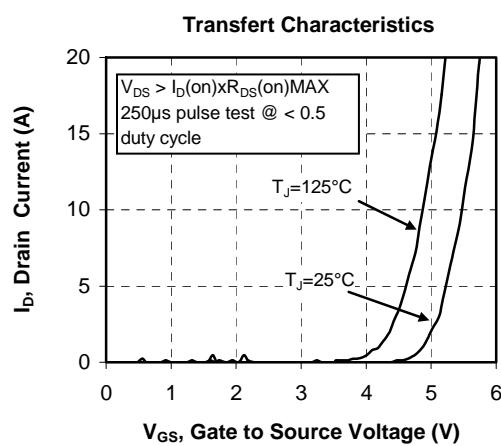
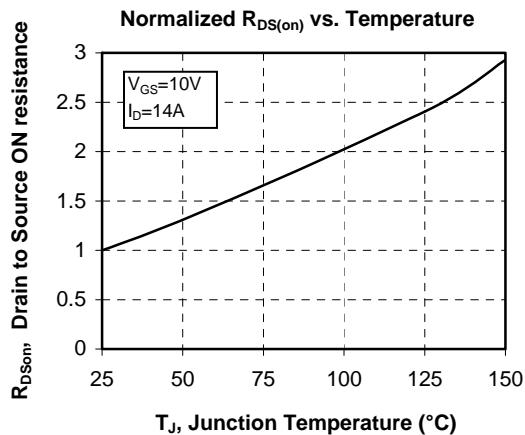
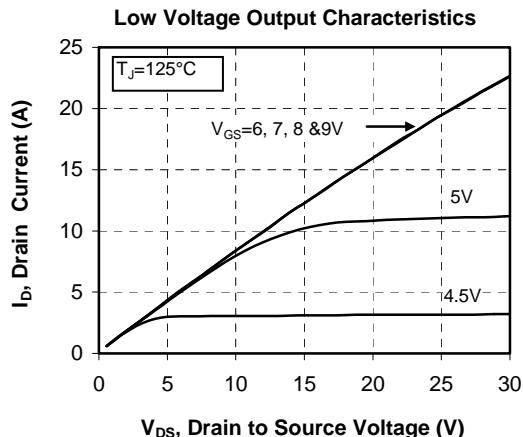
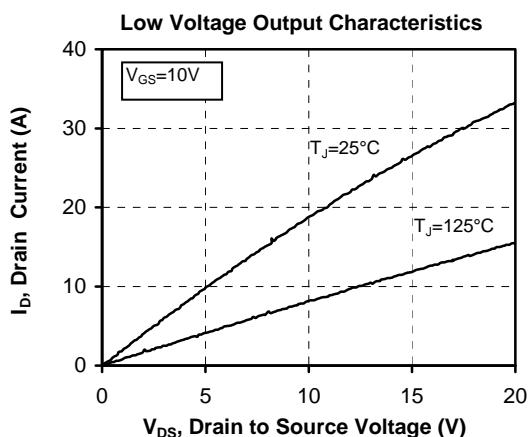
**Temperature sensor NTC** (see application note APT0406 on www.microsemi.com for more information).

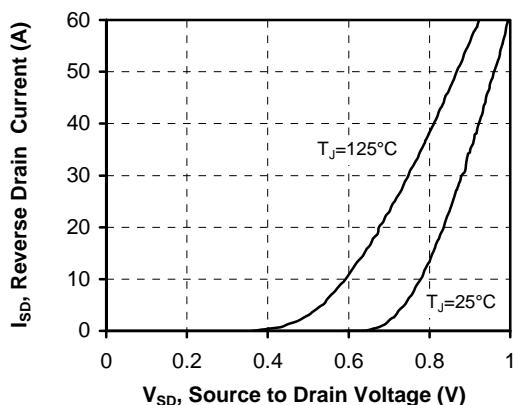
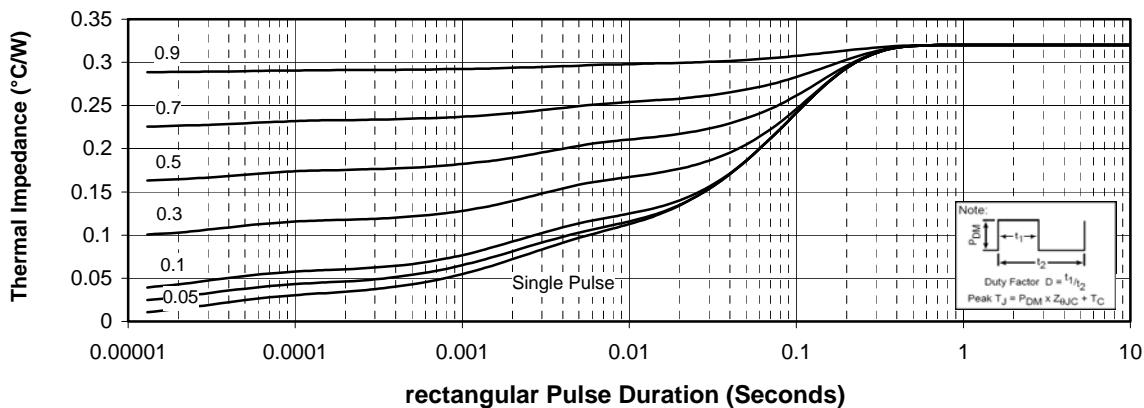
Symbol	Characteristic		Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C			50		kΩ
B <sub>25/85</sub>	T <sub>25</sub> = 298.15 K			3952		K

$$R_T = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]} \quad \begin{array}{l} T: \text{ Thermistor temperature} \\ R_T: \text{ Thermistor value at } T \end{array}$$

**SP1 Package outline** (dimensions in mm)

 See application note 1904 - Mounting Instructions for SP1 Power Modules on [www.microsemi.com](http://www.microsemi.com)

### Typical Performance Curve



**Drain Current vs Source to Drain Voltage**

**Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration**


Microsemi reserves the right to change, without notice, the specifications and information contained herein

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